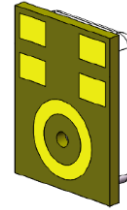




PUI audio



Data Sheet

DMM-3526-4-B

Features:

The DMM-3526-4-B digital MEMS microphone features a specialized pre-amplification ASIC that provides high sensitivity and high SNR output from a capacitive audio sensor. It's packaged for surface mounting and high temperature reflow assembly. The digital data format is single-bit PDM.

- -26dBFS sensitivity
- 65dB Signal-to-Noise
- Digital PDM output
- Small 2.65mm x 3.5mm surface-mount package

Specifications (f_{CLOCK} = 2.4MHz, V_{DD} = 1.8V, unless otherwise specified.)

Parameter	Test Condition	Value	Unit
Sensitivity	f _{IN} = 1 kHz 94dB SPL All operating modes	-27 (min) -26 (typ) -25 (max)	dBFS
Supply Voltage		1.8 (typ)	V _{DD}
Supply Voltage Range		1.62 (min) 3.6 (max)	V _{DD}
Supply Current	V _{dd} = 1.8V f _{SAMPLE} = 3.072MHz	650 (typ) 950 (max)	μA
Signal-to-Noise Ratio	f _{IN} = 1kHz 94dB SPL A-weighted	65 (typ)	dB
Frequency Range	See Frequency Response Curve for response limits	100 – 10k	Hz
Total Harmonic Distortion	f _{IN} = 1 kHz 94dB SPL	0.5 (max)	%
Acoustic Overload Point (AOP)	f _{IN} = 1kHz 10% THD	120 (typ)	dB
Power Supply Rejection	100mV _{PP} 217 Hz square wave on V _{DD} A-weighted	-90 (typ)	dB
Phase Response	50Hz < f _{IN} < 2000Hz 94dB SPL	-5 (min) 5 (max)	°

Specifications (f_{CLOCK} = 768kHz, V_{DD} = 1.8V, unless otherwise specified.)

Parameter	Test Condition	Value	Unit
Sensitivity	94dB SPL f _{IN} = 1 kHz All operating modes	-27 (min) -26 (typ) -25 (max)	dBFS
Supply Voltage		1.8 (typ)	V _{DD}
Supply Voltage Range		1.62 (min) 3.6 (max)	V _{DD}
Supply Current	V _{DD} = 1.8V f _{SAMPLE} = 768kHz	300 (typ) 450 (max)	μA
Signal-to-Noise Ratio	f _{IN} = 1kHz, 94dB SPL, A-weighted	65 (typ)	dB
Frequency Range	See Frequency Response Curve for response limits	100 – 10k	Hz
Total Harmonic Distortion	f _{IN} = 1kHz, 94dB SPL	0.5 (max)	%
Acoustic Overload Point (AOP)	(1kHz, 10% THD)	120 (typ)	dB
Power Supply Rejection	100mV _{PP} 217 Hz square wave on V _{DD} , A-weighted	-90 (typ)	dB

Physical Properties

Parameter	Condition	Value	Unit
Directivity		Omnidirectional	
Weight		0.3 (max)	Grams
Operating Temperature		-40 (min) 85 (max)	°C
Storage Temperature		-40 (min) 100 (max)	°C
MSL (Moisture Sensitivity Level)*		Class 1	
Acceptable Soldering Methods		See page 3 for reflow soldering information	
Environmental Compliances		RoHS/REACH/ Halogen Free	

*MSL level dependent on product remaining in sealed packaging until use

Operating Ratings

Parameter	Test Condition	Value	Unit
Power Supply Voltage (V_{DD})		1.62 (min) 1.8 (typ) 3.6 (max)	V
Clock Frequency Range (f_{CLOCK})	Sleep Mode	50 (max)	kHz
	Lower Power Mode	150 (min) 768 (typ) 900 (max)	kHz
	Standard Mode	1 (min) 3.072 (typ) 4.8 (max)	MHz
Clock Duty Cycle		40 (min) 60 (max)	%
Input Logic High Level		$0.65 \cdot V_{DD}$ (min) $V_{DD} + 0.3$ (max)	V
Input Logic Low Level		-0.3 (min) $0.35 \cdot V_{DD}$ (max)	
Output Logic High Level		$V_{DD} - 0.45$ (min)	V
Output Logic Low Level		0.45 (max)	
Output Logic Load Capacitance		200 (max)	pF
Short Circuit Current	Data Output Pin $V_{DD} = 1.8V$	1 (min) 20 (max)	mA

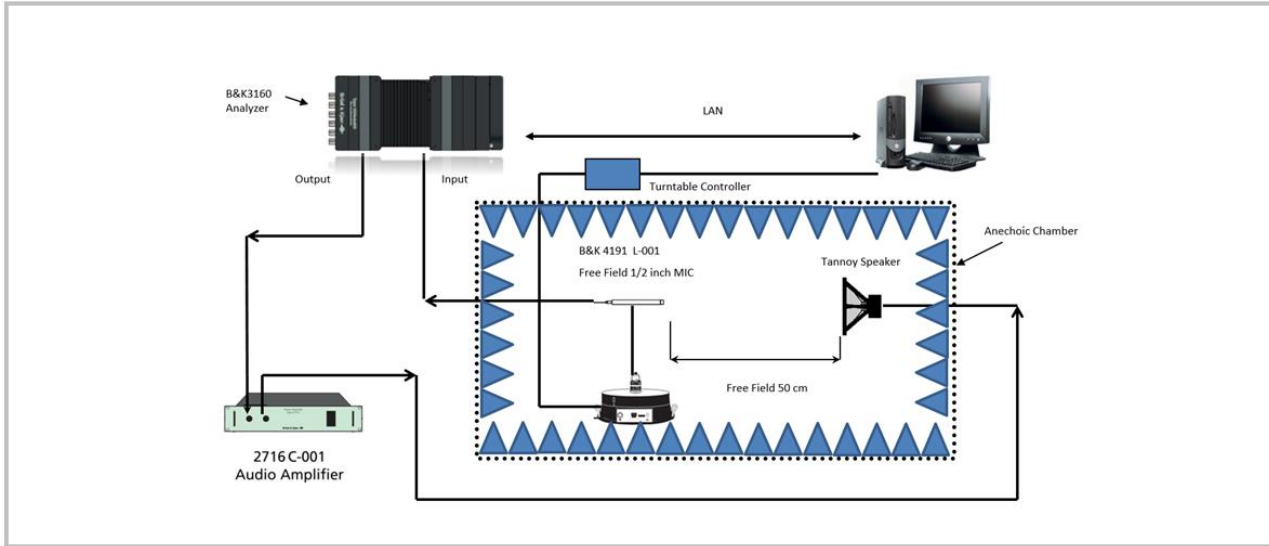
Timing Characteristics

Parameter	Test Condition	Value	Unit
Clock Timing Characteristics			
Clock Duty Cycle (DC_{CLOCK})		40 (min) 50 (typ) 60 (max)	%
Clock Rise Time (t_{CR})	10% to 90%	15 (max)	ns
Clock Fall Time (t_{CF})	90% to 10%	15 (max)	ns
Data Timing Characteristics			
Time Delay Between Clock Edge and Data Line Driven [DV _{DD} Mode] (t_{DD_DVDD})	DV _{DD} Digital Interface	24 (min)	ns
Time Delay to Valid Data [Normal Mode] (t_{DV_NM})	DV _{DD} Digital Interface: $f_{CLOCK} = 768kHz, 2.0MHz, 3.072MHz, \text{ or } 4.0MHz$	48 (max)	ns
Time Delay to High Impedance [DV _{DD} Mode] (t_{HZ_DVDD})	DV _{DD} Digital Interface	0 (min) 20 (min)	ns
Sleep Time	$f_{CLOCK} < 50kHz$	5 (typ)	μs
Wake Time	$f_{CLOCK} > 150kHz$	30 (typ)	μs
Power Valid Time		35 (typ)	μs
Mode Change Time		10 (max)	μs
Data Valid Time		24 (min) 36 (typ) 48 (max)	ns
Clock Jitter	RMS period jitter	0.5 (max)	ns

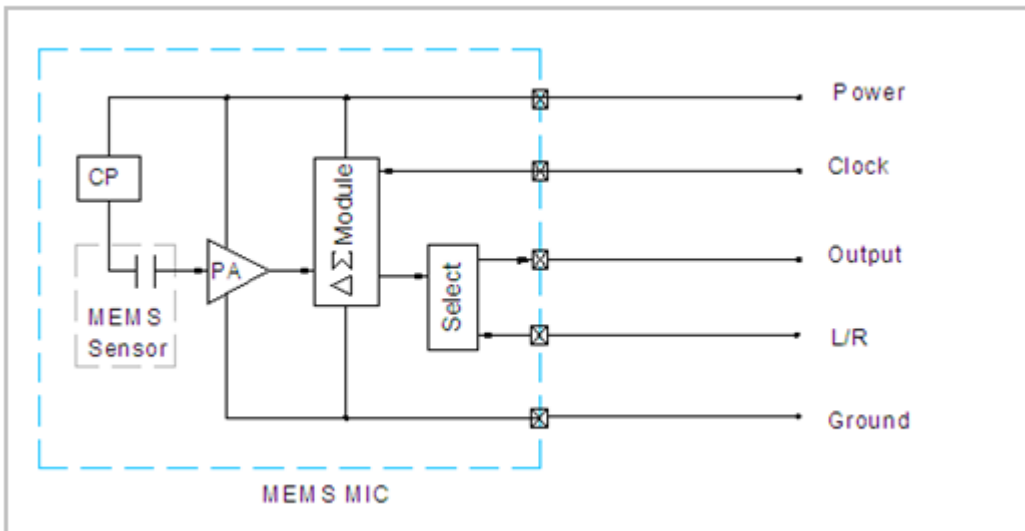
Absolute Maximum Ratings

Parameter	Condition	Value	Unit
Max Voltage on Any Pin		3.6	V _{DC}
Voltage on Any Pin		-0.3 (min) V _{DD} + 0.3 (max)	V _{DC}
Max Sound Pressure Level		160	dB
Max Mechanical Shock		10000	G
Max Vibration		Pre-MIL-STD-883 Method 2007, Test Condition B	

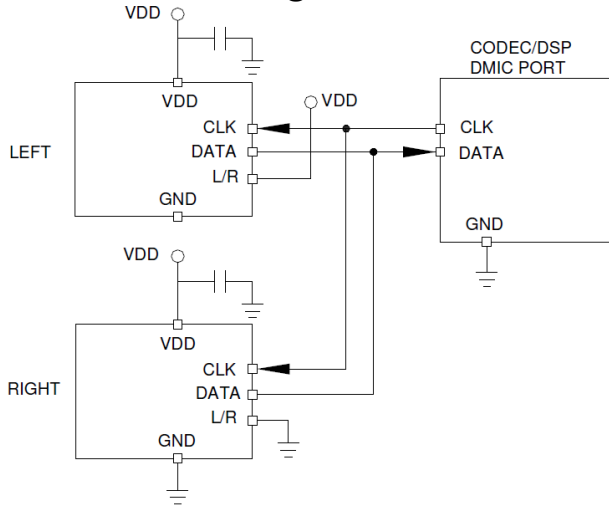
Measurement Method



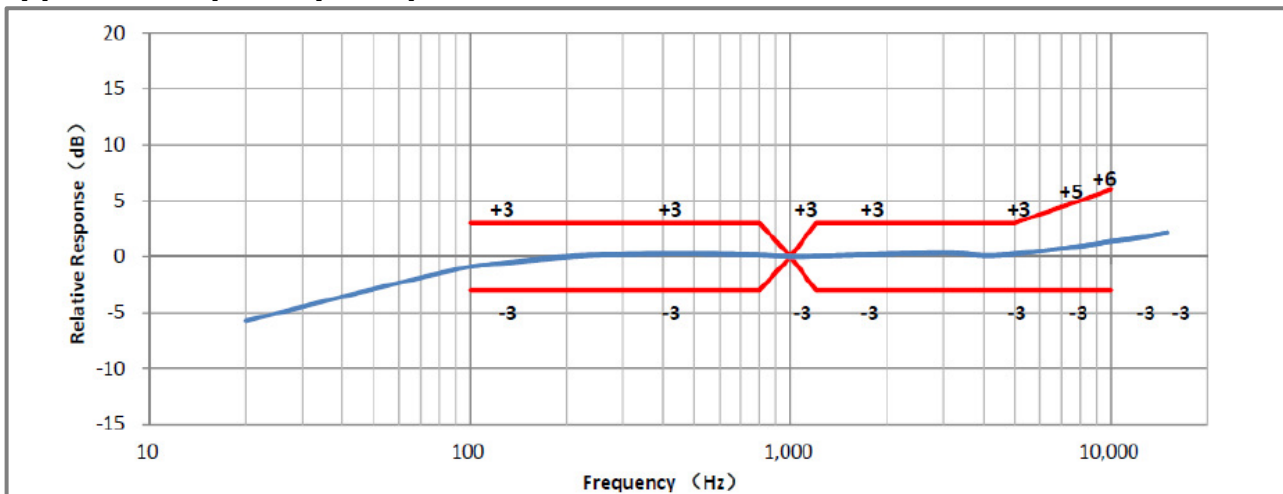
Measurement Circuit



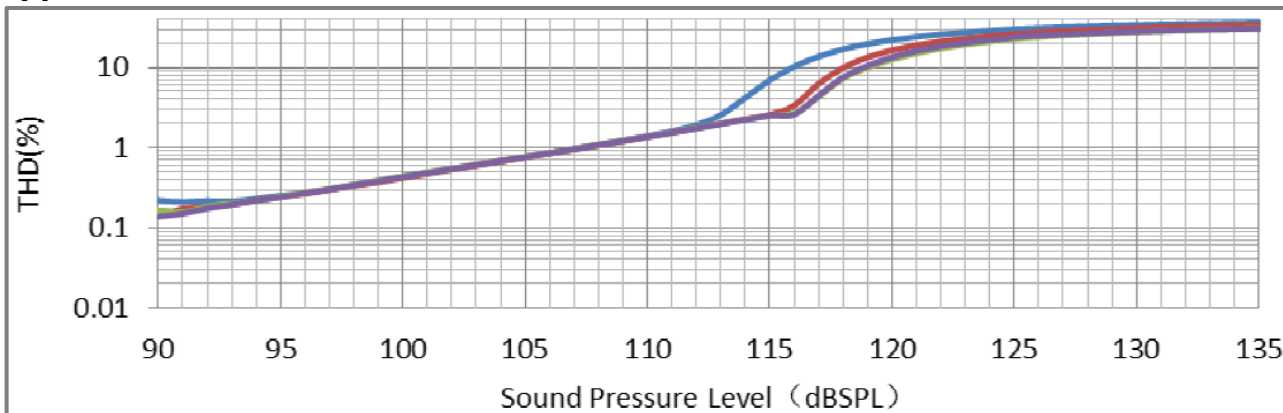
Connection Diagram



Typical Frequency Response (Normalized to 0dB at 1kHz)

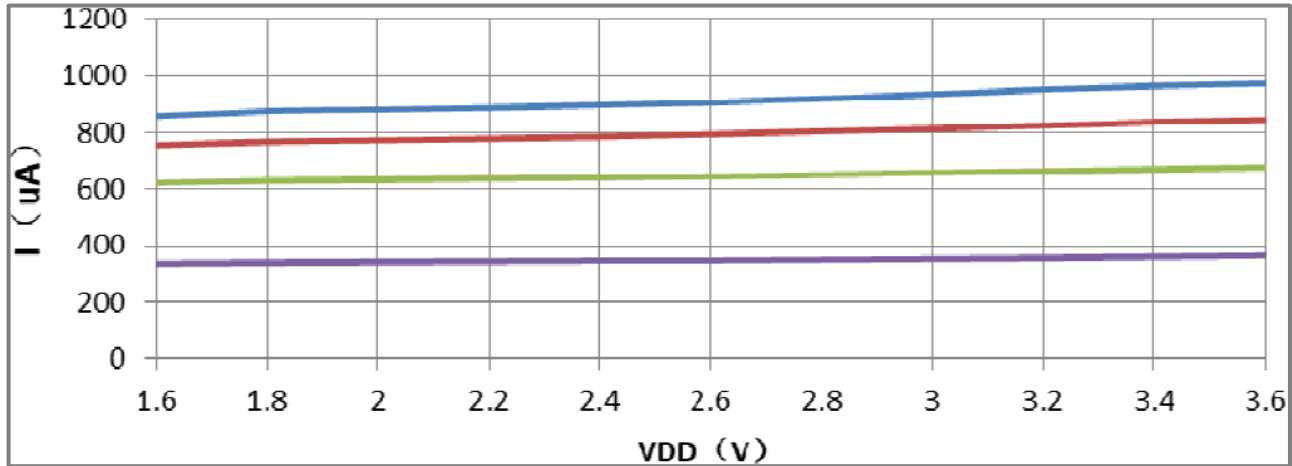


Typical THD vs. Sound Pressure Level



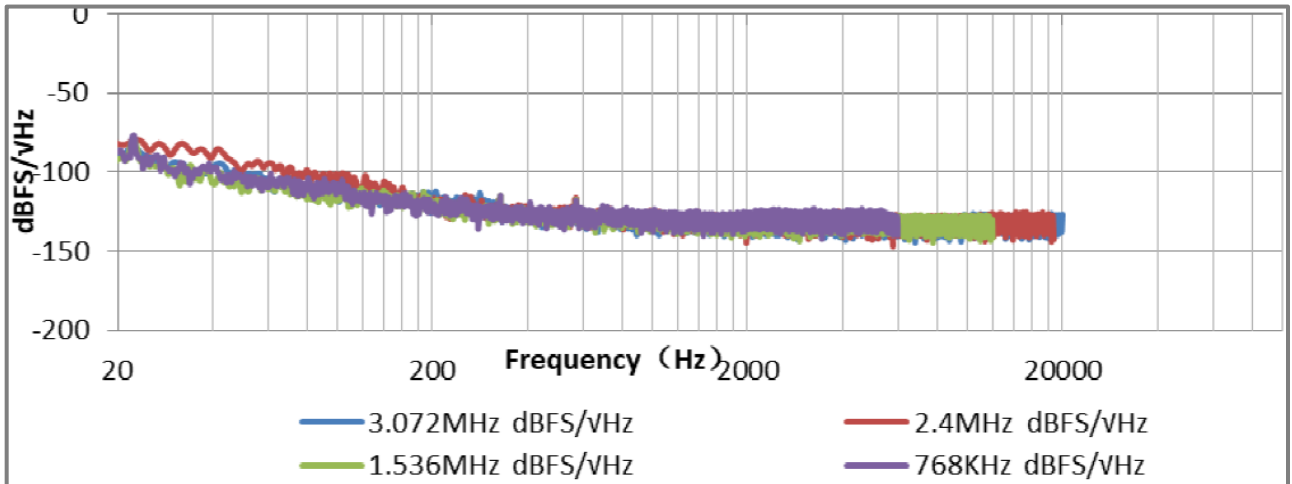
f_{clock}: — = 3.072MHz; — = 2.400MHz; — = 1.536MHz; — = 0.768MHz

Typical I_{DD} vs. V_{DD}

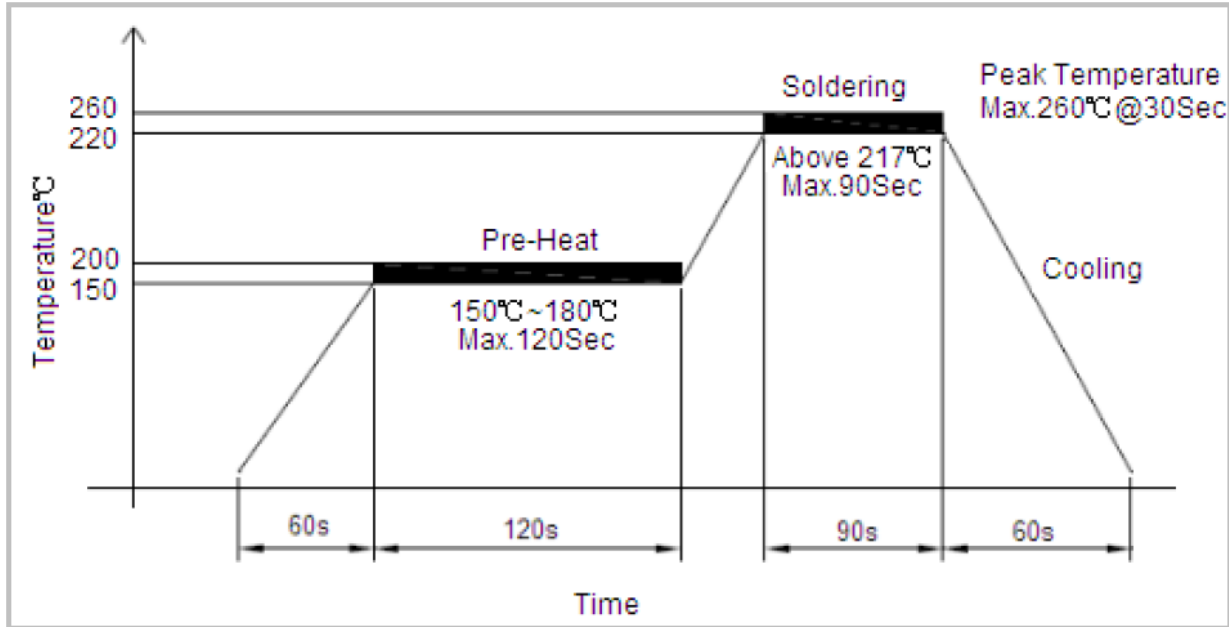


f_{Clock} : _____ = 3.072MHz; _____ = 2.400MHz; _____ = 1.536MHz; _____ = 0.768MHz

Typical Noise Floor vs. Frequency



Recommended Reflow Soldering Procedure (Recommended profile, temperature $\leq 260^{\circ}\text{C}$, 30s maximum at peak temperature)



Important notes to minimize device damage

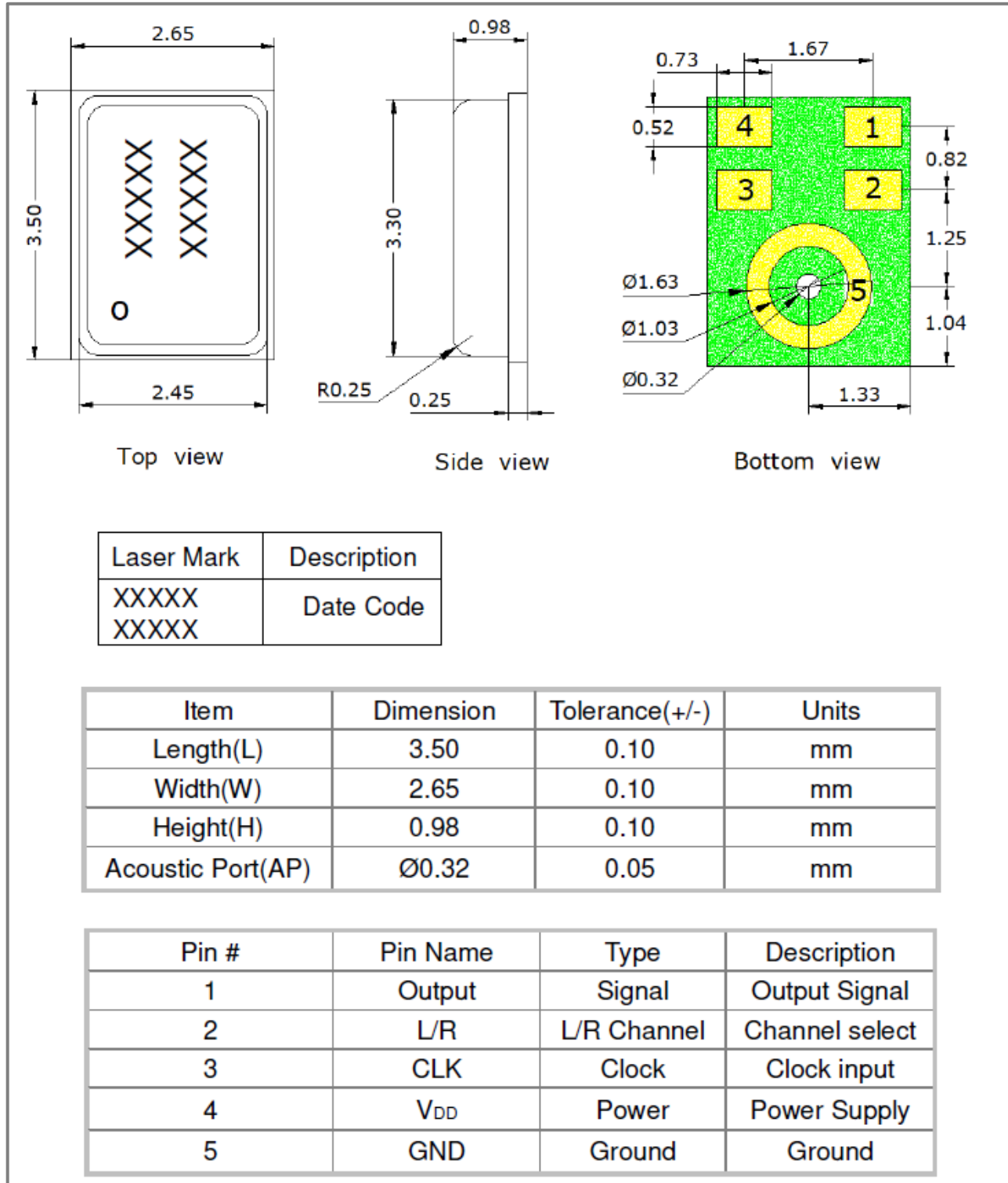
1. Do not handle the microphone with pick-and-place vacuum tools that could contact the microphone acoustic port hole.
2. Never expose the microphone's acoustic port hole to vacuum. Such exposure can damage or destroy the MEMS element.
3. Never allow air to blow air into the microphone acoustic port hole. The port hole must be sealed to prevent particle contamination if a blown air-cleaning process is used.
4. A clean room environment is recommended for PCB assembly to avoid microphone contamination.
5. Do not use blown air or ultrasonic cleaning procedures on MEMS Microphones. A no-clean paste is recommended for the assembly, avoiding subsequent cleaning steps. cleaning substances can severely damage the microphone MEMS element.
6. it is recommended to cover the sound port with protective tape during PCB sawing or system assembly. This prevents blocking or partially blocking the acoustic port hole during PCB assembly.
7. Do not use excessive force to place the microphone on the PCB. Use industry standard pick and place tools to limit the mechanical force exerted on the package.

Reliability Testing (Samples under test are acclimated at $T_A = 23 \pm 2^\circ\text{C}$, R.H. = $55 \pm 10\%$ for two hours. After each test completes and corresponding recovery time (if applicable) elapses, any measured sensitivity change is $\leq \pm 3\text{dB}$, unless otherwise specified)

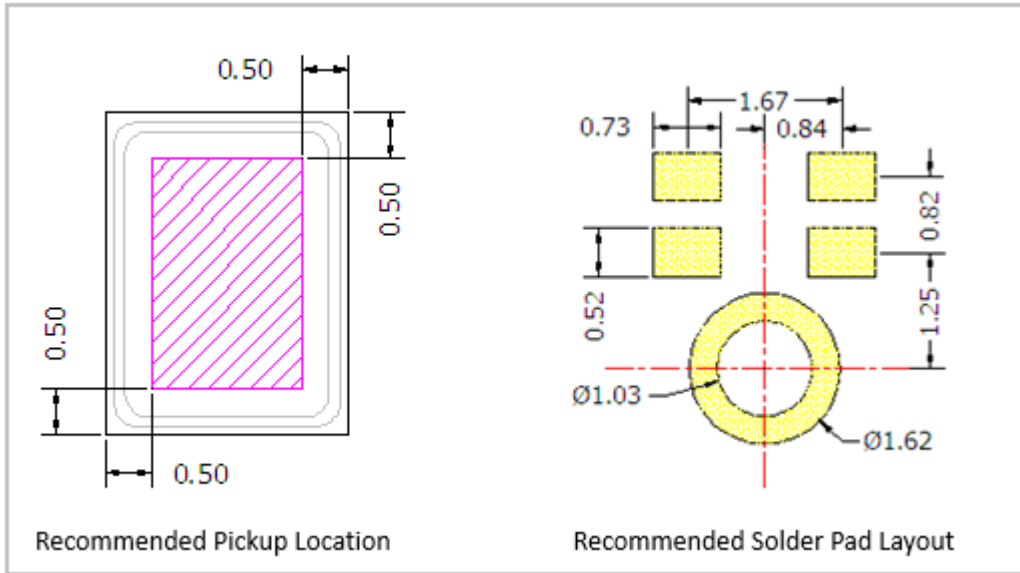
Type of Test	Test Specifications
High Temperature Storage Test	1000hrs at $105 \pm 3^\circ\text{C}$, two-hour recovery
High Temperature Operational Test	1000hrs at $105 \pm 3^\circ\text{C}$, $V_{DD} = V_{DD} (\text{max})$, four-hour recovery
Low Temperature Storage Test	1000hrs at $-40 \pm 3^\circ\text{C}$, two-hour recovery
Low Temperature Operational Test	1000hrs at $-40 \pm 3^\circ\text{C}$, $V_{DD} = V_{DD} (\text{max})$, four-hour recovery
Temperature-Cycle Testing	30min at $-40 \pm 3^\circ\text{C}$ Followed by 30min at $125 \pm 3^\circ\text{C}$ Five-minute transition 30 cycles
High Humidity, High Temperature Operating Test	1000hrs at $85 \pm 3^\circ\text{C}$ and 85%RH, $V_{DD} = V_{DD} (\text{max})$, twelve-hour recovery, no corrosion or defamation inside the microphone
High Humidity, High Temperature Operating Test	168hrs at $65 \pm 3^\circ\text{C}$ and 95%RH, $V_{DD} = V_{DD} (\text{max})$, twelve-hour recovery, no corrosion or defamation inside the microphone
Static Humidity	One hour at 25°C precondition 1000hrs at $85 \pm 3^\circ\text{C}$ and 85%RH Dry at room ambient temperature
Vibration Test	Twelve minutes along the x, y, and z axis $f_{IN} = 20\text{Hz}$ to 2kHz 20G peak acceleration Two-hour recovery Less than 1dB sensitivity change
Shock Test	Half sine shock pulses $3000\text{g} \pm 15\%$ for 0.3ms 6 times in each of X/Y/Z directions
Drop Test	Height: 1.5m Fixture weight: $150 \pm 10\text{g}$ Fixture's sound hole diameter is $\geq 0.8\text{mm}$ Reference surface is marble floor Duration: four corners x four times; six faces x four times Less than 1dB sensitivity change

Simulated Reflow (without solder)	Samples are qualified with three $260\pm 5^{\circ}\text{C}$ reflow profile passes Two hours of settling is required between each reflow profile test
ESD Sensitivity	Measured according to MIL-STD-883G, Method 3015.7, Human Body Model (HBM) Identify ESD threshold levels indicating 3000V HBM passage.
Operational Life	Samples tested at 125°C for 168hrs at $V_{\text{DD}(\text{MAX})}$

Dimensions (Dimension are in mm.)

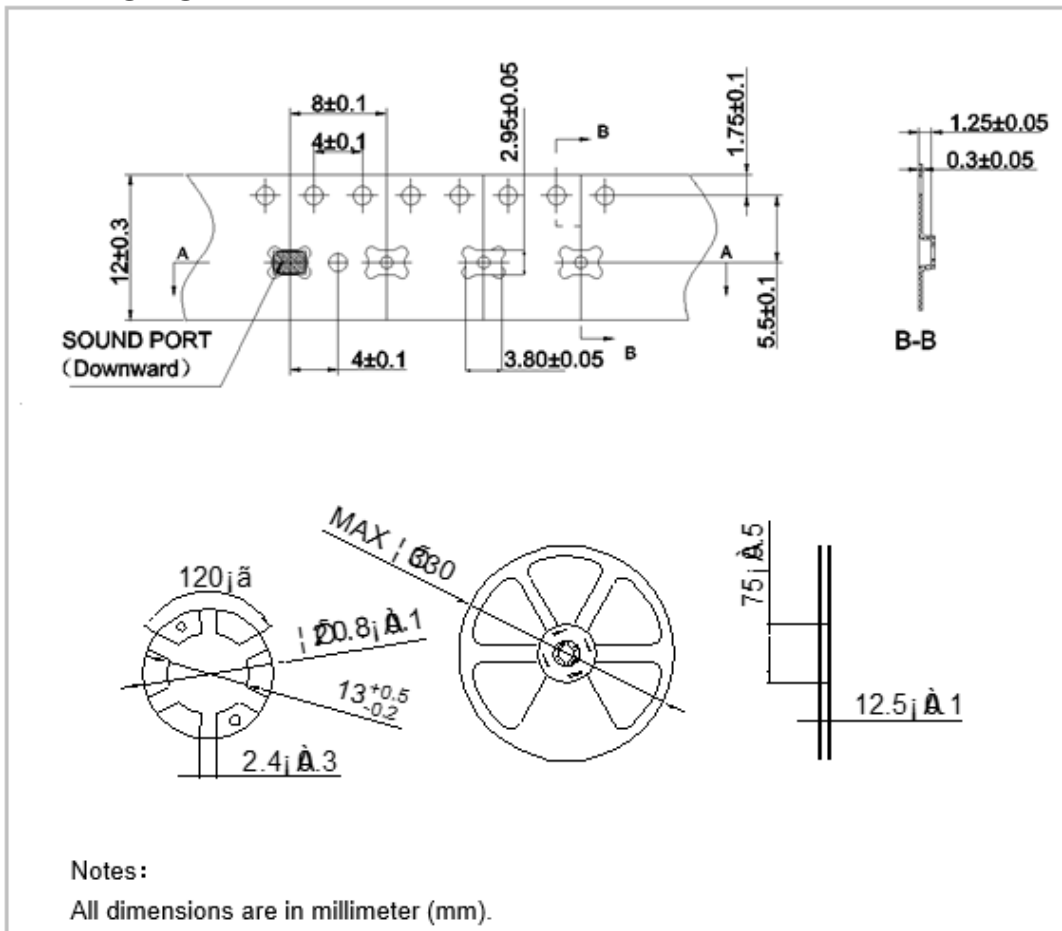


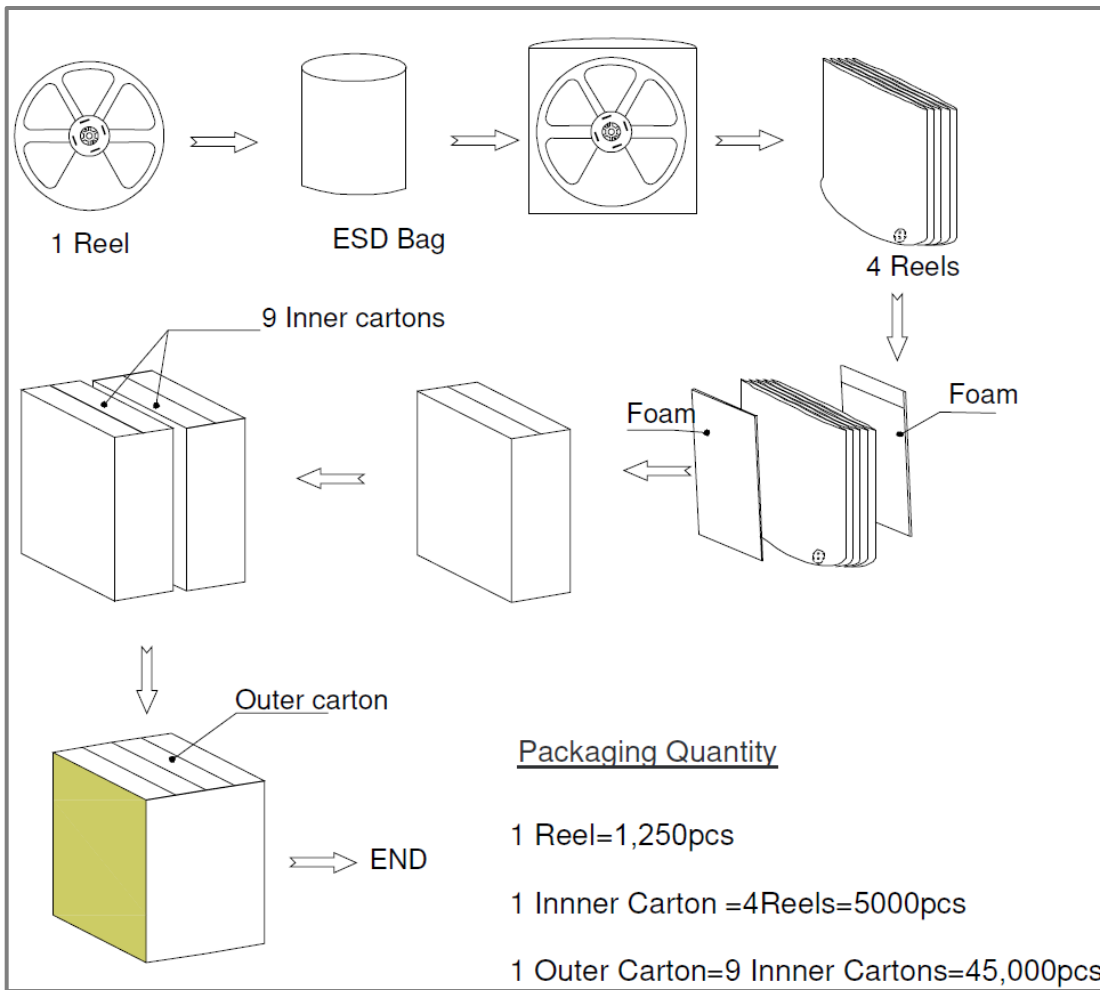
Suggested Land Pattern*



*This land pattern is advisory only and its use or adaptation is entirely voluntary. PUI Audio disclaims all liability of any kind associated with the use, application, or adaptation of this land pattern.

Packaging





Specifications Revisions

Revision	Description	Date
A	Released from Engineering	5/9/2023

Note:

1. Unless otherwise specified:
 - A. All dimensions are in millimeters.
 - B. Default tolerances are $\pm 0.5\text{mm}$ and angles are $\pm 3^\circ$.
2. Specifications subject to change or withdrawal without notice.
3. This part is ROHS 2015/863/EU compliant.